TLC27xx Precision Quad Operational Amplifiers

1 Features

- Wide range of supply voltages over specified temperature range:
  - 0°C to 70°C: 3V to 16V
  - –40°C to 125°C: 4V to 16V
  - –55°C to 125°C: 4V to 16V
- Single-supply operation
- Common-mode input voltage range extends below the negative rail (C-suffix, I-suffix types)
- Low noise: typically 10.8nV/√Hz at f = 1kHz
- Output voltage range includes negative rail
- High input impedance: $>10^{12}$ Ω typical
- ESD-protection circuitry
- Small-outline package option also available in tape and reel
- Designed-in latch-up immunity

2 Description

The TLC274 and TLC279 precision quad operational amplifiers combine a wide range of input offset voltage grades with low offset voltage drift, high input impedance, low noise, and speeds approaching those of general-purpose BiFET devices.

The extremely high input impedance, low bias currents, and boosted slew rates make these cost effective devices an excellent choice for applications previously reserved for BiFET and NFET products. Four offset voltage grades are available (C-suffix and I-suffix types), ranging from the low-cost TLC274 (10mV) to the high-precision TLC279 (900µV). These advantages, in combination with good common-mode rejection and supply voltage rejection, make these devices a good choice for new state-of-the-art designs as well as for upgrading existing designs.

Device Information

PART NUMBER	PACKAGE(1)	PACKAGE SIZE(2)
TLC274	N (PDIP, 14)	19.3mm × 9.4mm
	D (SOIC, 14)	8.65mm × 6mm
	NS (SOP, 14)	10.2mm × 7.8mm
	DB (SSOP, 14)	6.2mm × 7.8mm
	PW (TSSOP, 14)	5mm × 6.4mm
TLC274A	N (PDIP, 14)	19.3mm × 9.4mm
	D (SOIC, 14)	8.65mm × 6mm
TLC274B	N (PDIP, 14)	19.3mm × 9.4mm
	D (SOIC, 14)	8.65mm × 6mm
	NS (SOP, 14)	10.2mm × 7.8mm
TLC279	N (PDIP, 14)	19.3mm × 9.4mm
	D (SOIC, 14)	8.65mm × 6mm

(1) For more information, see Section 9.
(2) The package size (length × width) is a nominal value and includes pins, where applicable.

An IMPORTANT NOTICE at the end of this data sheet addresses availability, warranty, changes, use in safety-critical applications, intellectual property matters and other important disclaimers. PRODUCTION DATA.

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3 Pin Configuration and Functions

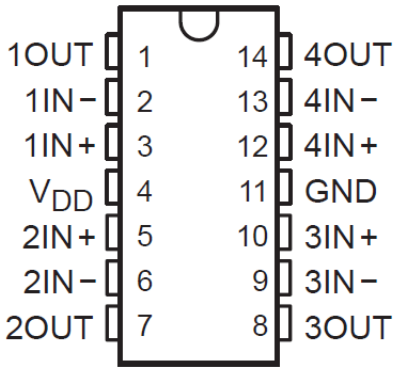

Figure 3-1. D, J, N, or PW Package, 14-Pin SOIC, SOP, PDIP, SSOP, or TSSOP (Top View)

Table 3-1. Pin Functions

PIN NAME	PIN NO.	TYPE	DESCRIPTION
1OUT	1	Output	Output, channel 1
1IN–	2	Input	Inverting input, channel 1
1IN+	3	Input	Noninverting input, channel 1
VDD	4	—	Positive (highest) power supply
2IN+	5	Input	Noninverting input, channel 2
2IN–	6	Input	Inverting input, channel 2
2OUT	7	Output	Output, channel 2
3OUT	8	Output	Output, channel 3
3IN–	9	Input	Inverting input, channel 3
3IN+	10	Input	Noninverting input, channel 3
GND	11	—	Negative (lowest) power supply or Ground
4IN+	12	Input	Noninverting input, channel 4
4IN–	13	Input	Inverting input, channel 4
4OUT	14	Output	Output, channel 4

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4 Specifications

4.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) (1)

			MIN	MAX	UNIT
V_{DD}	Supply voltage(2)			18	V
V_{ID}	Differential input voltage(3)		$-V_{DD}$	$+V_{DD}$	
V_I	Input voltage range	Any input	–0.3	V_{DD}	V
I_I	Input current		–5	5	mA
I_O	Output current	Each output	–30	30	mA
	Total current into V_{DD}			45	mA
	Total current out of GND			45	mA
	Duration of short-circuit current at (or below) 25°C(4)			Unlimited	
T_A	Operating free-air temperature	C suffix	0	70	°C
		I suffix	–40	85	
T_{stg}	Storage temperature		–65	150	°C
	Lead temperature 1,6mm (1/16 inch) from case for 10 seconds	D package		260	°C
		P package			
		PW package			
	Lead temperature 1,6mm (1/16 inch) from case for 60 seconds	JG package		300	°C

(1) Stresses beyond those listed under Section 4.1 can cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under Section 4.2 is not implied. Exposure to absolute-maximum-rated conditions for extended periods can affect device reliability.
(2) All voltage values, except differential voltages, are with respect to network ground.
(3) Differential voltages are at IN+ with respect to IN –.
(4) The output can be shorted to either supply. Temperature and/or supply voltages must be limited to make sure that the maximum dissipation rating is not exceeded (see application section).

4.2 Recommended Operating Conditions

			C SUFFIX		I SUFFIX		UNIT
			MIN	MAX	MIN	MAX	
V_{DD}	Supply voltage		3	16	4	16	V
V_{IC}	Common-mode input voltage	V_{DD} = 5V	–0.2	3.5	–0.2	3.5	V
		V_{DD} = 10V	–0.2	8.5	–0.2	8.5	
T_A	Operating free-air temperature		0	70	–40	85	°C

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4.3 Electrical Characteristics

at specified free-air temperature, V_{DD} =5V (unless otherwise noted)

PARAMETER			TEST CONDITIONS		T_A (1)	TLC274C, TLC274AC, TLC274BC, TLC279C			UNIT
						MIN	TYP	MAX	
V_{IO}	Input offset voltage	TLC274C	V_O = 1.4V, R_S = 50Ω	V_{IC} = 0, R_L = 10kΩ	25°C		0.12	10	mV
					Full range			12	
		TLC274AC	V_O = 1.4V, R_S = 50Ω	V_{IC} = 0, R_L = 10kΩ	25°C		0.12	5	
					Full range			6.5	
		TLC274BC	V_O = 1.4V, R_S = 50Ω	V_{IC} = 0, R_L = 10kΩ	25°C		120	2000	µV
					Full range			3000	
		TLC279C	V_O = 1.4V R_S = 50Ω	V_{IC} = 0 R_L = 10kΩ	25°C		120	900	
					Full range			1500	
a_{VIO}	Temperature coefficient of input offset voltage				25°C to 70°C		0.3		µV/°C
I_{IO}	Input offset current(2)		V_O = 2.5V	V_{IC} =2.5 V	25°C		10	60	pA
					70°C		7	300	
I_{IB}	Input bias current(2)				25°C		10	60	pA
					70°C		40	600	
V_{ICR}	Common-mode input voltage range(3)				25°C	–0.1 to 4	–0.3 to 4.2		V
					Full range	–0.1 to 3.5			V
V_{OH}	High-level output voltage		V_{ID} = 100mV	R_L = 10kΩ	25°C	3.2	4.95		V
					0°C	3	4.95		
					70°C	3	4.95		
V_{OL}	Low-level output voltage		V_{ID} = –100 mV	I_{OL} = 0	25°C		0	50	mV
					0°C		0	50	
					70°C		0	50	
A_{VD}	Large-signal differential voltage amplification		V_O = 0.25V to 2V	R_L = 10kΩ	25°C	5	1000		V/mV
					0°C	4			
					70°C	4			
CMRR	Common-mode rejection ratio		V_{IC} = –0.1V < VIC < 3V		25°C	65	80		dB
					0°C	60			
					70°C	60			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{DD}/\Delta V_{IO}$)		V_{DD} = 5V to 10V	V_O =1.4 V	25°C	65	120		dB
					0°C	60			
					70°C	60			
I_{DD}	Supply current (four amplifiers)		V_O = 2.5V, No load	V_{IC} = 2.5V,	25°C		2.24	6.4	mA
					0°C			7.2	
					70°C			5.2	

(1) Full range is 0°C to 70°C.
(2) The typical values of input bias current and input offset current below 5pA were determined mathematically.
(3) This range also applies to each input individually.

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4.4 Electrical Characteristics

at specified free-air temperature, V_{DD} = 10V (unless otherwise noted)

PARAMETER			TEST CONDITIONS		T_A [1]	TLC274C, TLC274AC, TLC274BC, TLC279C			UNIT
						MIN	TYP	MAX	
V_{IO}	Input offset voltage	TLC274C	V_O = 1.4V, R_S = 50Ω,	V_{IC} = 0, R_L = 10kΩ	25°C		0.12	10	mV
					Full range			12	
		TLC274AC	V_O = 1.4V, R_S = 50Ω	V_{IC} = 0, R_L = 10kΩ	25°C		0.12	5	
					Full range			6.5	
		TLC274BC	V_O = 1.4V, R_S = 50Ω	V_{IC} = 0, R_L = 10kΩ	25°C		120	2000	µV
					Full range			3000	
		TLC279C	V_O = 1.4V, R_S = 50Ω	V_{IC} = 0 R_L = 10kΩ	25°C		120	1200	
					Full range			1900	
a_{VIO}	Temperature coefficient of input offset voltage				25°C to 70°C		0.3		µV/°C
I_{IO}	Input offset current[2]		V_O = 5V	V_{IC} = 5V	25°C		10	60	pA
					70°C		7	300	
I_{IB}	Input bias current[2]				25°C		10	60	pA
					70°C		50	600	
V_{ICR}	Common-mode input voltage range[3]				25°C	–0.1 to 9	–0.3 to 9.2		V
					Full range	–0.1 to 8.5			V
V_{OH}	High-level output voltage		V_{ID} = 100mV	R_L = 10kΩ	25°C	8	9.95		V
					0°C	7.8			
					70°C	7.8			
V_{OL}	Low-level output voltage		V_{ID} = –100 mV	I_{OL} = 0	25°C		0	50	mV
					0°C		0	50	
					70°C		0	50	
A_{VD}	Large-signal differential voltage amplification		V_O = 1V to 6V	R_L = 10kΩ	25°C	10	1000		V/mV
					0°C	7.5			
					70°C	7.5			
CMRR	Common-mode rejection ratio		V_{IC} = -0.1V < V_{IC} < 8V		25°C	65	85		dB
					0°C	60			
					70°C	60			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{DD}/\Delta V_{IO}$)		V_{DD} = 5V to 10V	V_O = 1.4V	25°C	65	120		dB
					0°C	60			
					70°C	60			
I_{DD}	Supply current (four amplifiers)		V_O = 5V, No load	V_{IC} = 5V	25°C		2.24	8	mA
					0°C			8.8	
					70°C			6.8	

(1) Full range is 0°C to 70°C.
(2) The typical values of input bias current and input offset current below 5pA were determined mathematically.
(3) This range also applies to each input individually.

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4.5 Electrical Characteristics

at specified free-air temperature, V_{DD} = 5V (unless otherwise noted)

PARAMETER			TEST CONDITIONS		T_A [1]	TLC274I, TLC274AI, TLC274BI, TLC279I			UNIT
						MIN	TYP	MAX	
V_{IO}	Input offset voltage	TLC274I	V_O = 1.4V, R_S = 50Ω	V_{IC} = 0, R_L = 10kΩ	25°C		0.12	10	mV
					Full range			13	
		TLC274AI	V_O = 1.4V, R_S = 50Ω	V_{IC} = 0, R_L = 10kΩ	25°C		0.12	5	
					Full range			7	
		TLC274BI	V_O = 1.4V, R_S = 50Ω	V_{IC} = 0, R_L = 10kΩ	25°C		120	2000	μV
					Full range			3500	
		TLC279I	V_O = 1.4V, R_S = 50Ω	V_{IC} = 0, R_L = 10kΩ	25°C		120	500	
					Full range			2000	
a_{VIO}	Temperature coefficient of input offset voltage				25°C to 85°C		0.3		μV/°C
I_{IO}	Input offset current[2]		V_O = 2.5V,	V_{IC} = 2.5V	25°C		10	60	pA
					85°C		24	15	
I_{IB}	Input bias current[2]				25°C		10	60	pA
					85°C		200	35	
V_{ICR}	Common-mode input voltage range[3]				25°C	–0.1 to 4	–0.3 to 4.2		V
					Full range	–0.1 to 3.5			V
V_{OH}	High-level output voltage		V_{ID} = 100mV	R_L = 10kΩ	25°C	3.2	4.95		V
					–40°C	3	4.95		
					85°C	3	4.95		
V_{OL}	Low-level output voltage		V_{ID} = –100 mV	I_{OL} = 0	25°C		0	50	mV
					–40°C		0	50	
					85°C		0	50	
A_{VD}	Large-signal differential voltage amplification		V_O = 1V to 6V	R_L = 10kΩ	25°C	5	1000		V/mV
					–40°C	3.5			
					85°C	3.5			
CMRR	Common-mode rejection ratio		V_{IC} = –0.1 V < V_{IC} < 3V		25°C	65	80		dB
					–40°C	60			
					85°C	60			
k_{SVR}	Supply-voltage rejection ratio (ΔV_{DD} /ΔV_{IO})		V_{DD} = 5V to 10V	V_O = 1.4V	25°C	65	120		dB
					–40°C	60			
					85°C	60			
I_{DD}	Supply current (four amplifiers)		V_O = 2.5V, No load	V_{IC} = 2.5V	25°C		2.24	6.4	mA
					–40°C			8.8	
					85°C			4.8	

(1) Full range is – 40°C to 85°C.
(2) The typical values of input bias current and input offset current below 5pA were determined mathematically.
(3) This range also applies to each input individually.

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4.6 Electrical Characteristics

at specified free-air temperature, V_{DD} =10V (unless otherwise noted)

PARAMETER			TEST CONDITIONS		T_A [1]	TLC274I, TLC274AI, TLC274BI, TLC279I			UNIT
						MIN	TYP	MAX	
V_{IO}	Input offset voltage	TLC274I	V_O = 1.4V R_S = 50Ω	V_{IC} = 0 R_L = 10kΩ	25°C		0.12	10	mV
					Full range			13	
		TLC274AI	V_O = 1.4V R_S = 50Ω	V_{IC} = 0 R_L = 10kΩ	25°C		0.12	5	
					Full range			7	
		TLC274BI	V_O = 1.4V R_S = 50Ω	V_{IC} = 0 R_L = 10kΩ	25°C		120	2000	µV
					Full range			3500	
		TLC279I	V_O = 1.4V R_S = 50Ω	V_{IC} = 0 R_L = 10kΩ	25°C		120	900	
					Full range			2000	
a_{VIO}	Temperature coefficient of input offset voltage				25°C to 85°C		0.3		µV/°C
I_{IO}	Input offset current[2]		V_O = 5V	V_{IC} = 5V	25°C		10	60	pA
					85°C		26	1000	
I_{IB}	Input bias current[2]				25°C		10	60	pA
					85°C		220	2000	
V_{ICR}	Common-mode input voltage range[3]				25°C	–0.1 to 9	–0.3 to 9.2		V
					Full range	–0.1 to 8.5			V
V_{OH}	High-level output voltage		V_{ID} = 100mV	R_L = 10kΩ	25°C	8	9.95		V
					–40°C	7.8			
					85°C	7.8			
V_{OL}	Low-level output voltage		V_{ID} = –100 mV,	I_{OL} = 0	25°C		0	50	mV
					–40°C		0	50	
					85°C		0	50	
A_{VD}	Large-signal differential voltage amplification		V_O = 1V to 6V	R_L = 10kΩ	25°C	5	1000		V/mV
					–40°C	3.5			
					85°C	3.5			
CMRR	Common-mode rejection ratio		V_{IC} = -0.1V < V_{IC} < 8V		25°C	65	85		dB
					–40°C	60			
					85°C	60	88		
kS_{SVR}	Supply-voltage rejection ratio (ΔV_{DD} /ΔV_{IO})		V_{DD} = 5V to 10V	V_O = 1.4V	25°C	65	120		dB
					–40°C	60			
					85°C	60			
I_{DD}	Supply current (quad amplifiers)		V_O = 5V, No load	V_{IC} = 5V,	25°C		2.24	8	mA
					–40°C			10	
					85°C			6.4	

(1) Full range is – 40°C to 85°C.
(2) The typical values of input bias current and input offset current below 5pA were determined mathematically.
(3) This range also applies to each input individually.

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4.7 Operating Characterisitcs

at specified free-air temperature, V_{DD} = 5V

PARAMETER		TEST CONDITIONS		T_A	TLC274I, TLC274AI,TLC274BI, TLC279I TLC274C, TLC274AC, TLC274BC, TLC279C			UNIT
					MIN	TYP	MAX	
SR	Slew rate at unity gain	R_L = 10kΩ C_L = 20pF	V_{IPP} = 100mV	25°C		0.5		V/µs
			V_{IPP} = 1V	25°C		21		
V_n	Equivalent input noise voltage	f = 1kHz	R_S = 20Ω	25°C		10.8		nV/√Hz
B_{OM}	Maximum output-swing bandwidth	$V_O = V_{OH}$ R_L = 10kΩ	C_L = 20pF	25°C		10		kHz
B_1	Unity-gain bandwidth	V_I = 10mV	C_L = 20pF,	25°C		4.5		MHz
φ_m	Phase margin	V_I = 10mV, C_L = 20pF,	f = B_1	25°C		60°		

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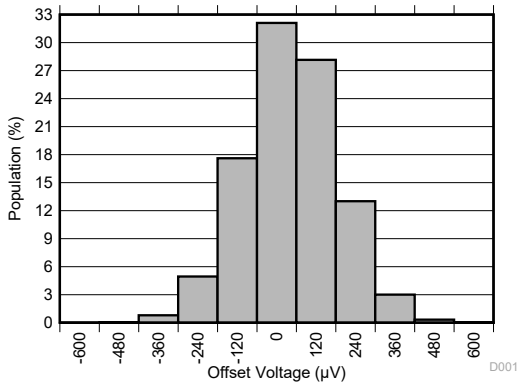
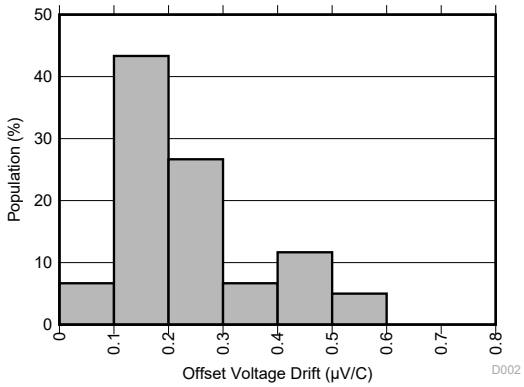
4.8 Typical Characteristics

at T_A = 25°C, V_S = ±20V, V_{CM} = V_S / 2, R_{LOAD} = 10kΩ connected to V_S / 2, and C_L = 10pF (unless otherwise noted)



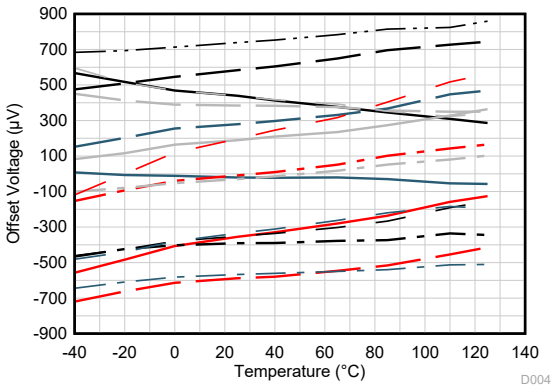
Distribution from 15462 amplifiers, T_A = 25°C

Figure 4-1. Offset Voltage Production Distribution



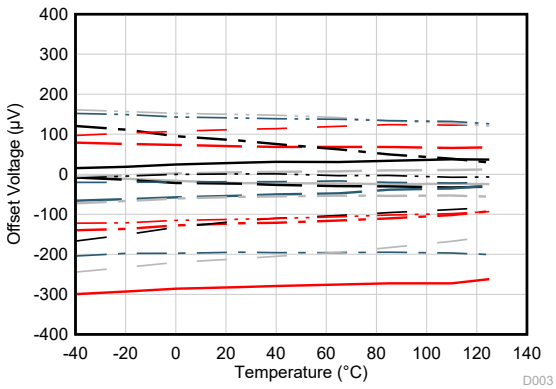
Distribution from 60 amplifiers

Figure 4-2. Offset Voltage Drift Distribution



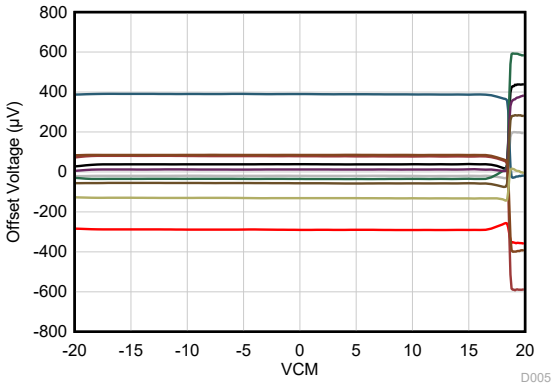
V_{CM} = V+

Figure 4-3. Offset Voltage vs Temperature



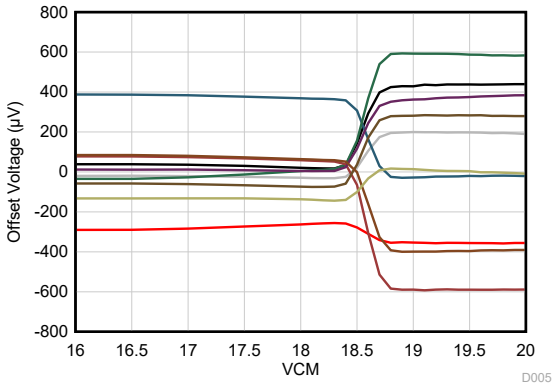
V_{CM} = V–

Figure 4-4. Offset Voltage vs Temperature



T_A = 25°C

Figure 4-5. Offset Voltage vs Common-Mode Voltage



T_A = 25°C

Figure 4-6. Offset Voltage vs Common-Mode Voltage (Transition Region)

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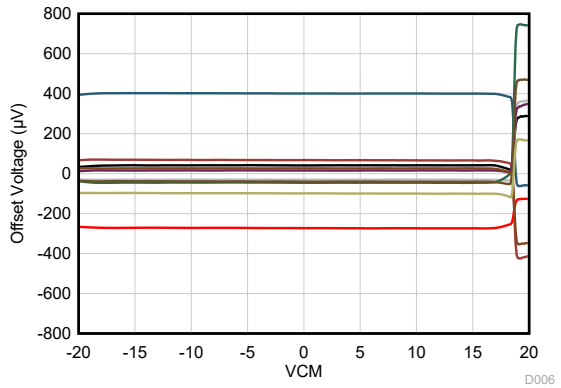
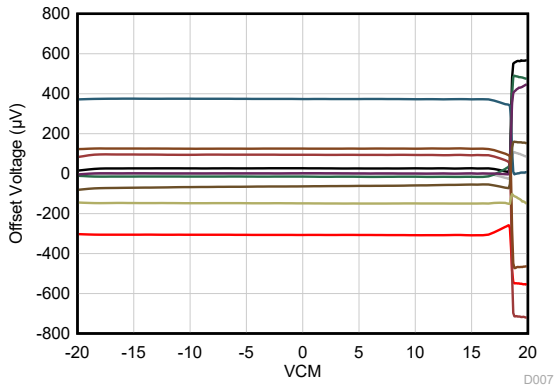
4.8 Typical Characteristics (continued)

at T_A = 25°C, V_S = ±20V, V_{CM} = V_S / 2, R_{LOAD} = 10kΩ connected to V_S / 2, and C_L = 10pF (unless otherwise noted)



T_A = 125°C

Figure 4-7. Offset Voltage vs Common-Mode Voltage



T_A = –40°C

Figure 4-8. Offset Voltage vs Common-Mode Voltage

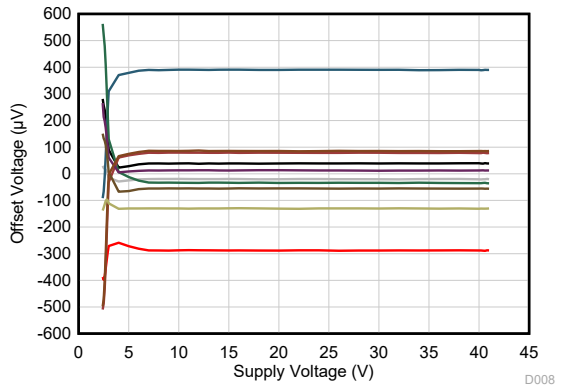
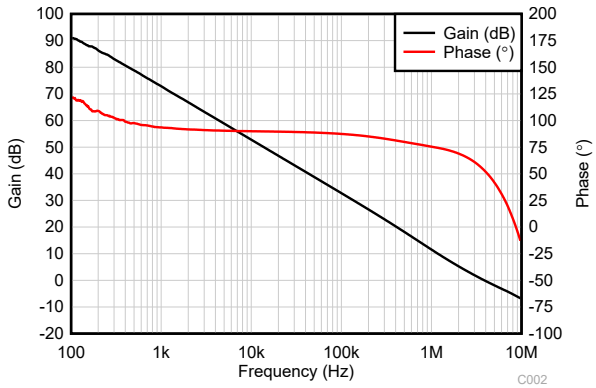


Figure 4-9. Offset Voltage vs Power Supply



C_L = 20pF

Figure 4-10. Open-Loop Gain and Phase vs Frequency

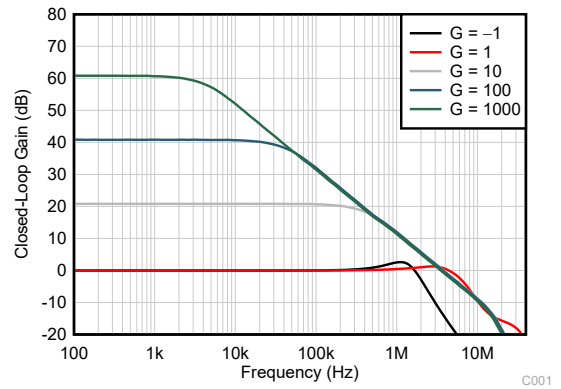


Figure 4-11. Closed-Loop Gain vs Frequency

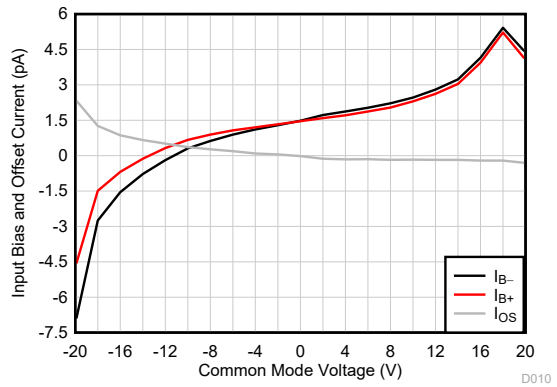


Figure 4-12. Input Bias Current vs Common-Mode Voltage

4.8 Typical Characteristics (continued)

at T_A = 25°C, V_S = ±20V, V_{CM} = V_S / 2, R_{LOAD} = 10kΩ connected to V_S / 2, and C_L = 10pF (unless otherwise noted)

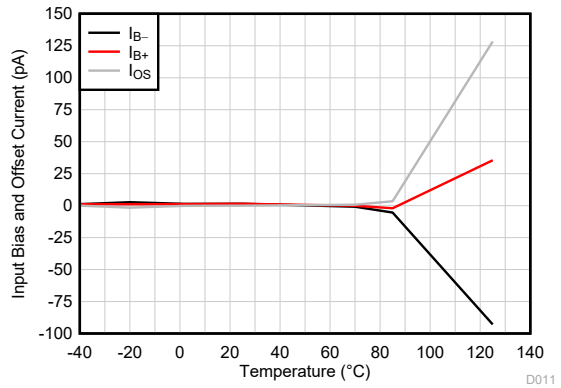


Figure 4-13. Input Bias Current vs Temperature

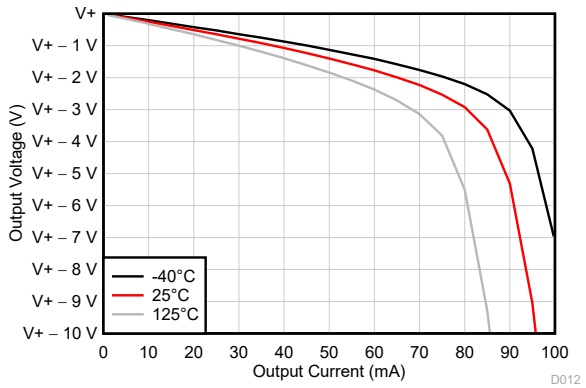


Figure 4-14. Output Voltage Swing vs Output Current (Sourcing)

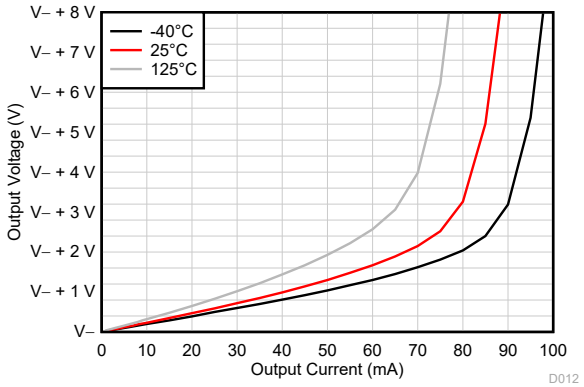


Figure 4-15. Output Voltage Swing vs Output Current (Sinking)

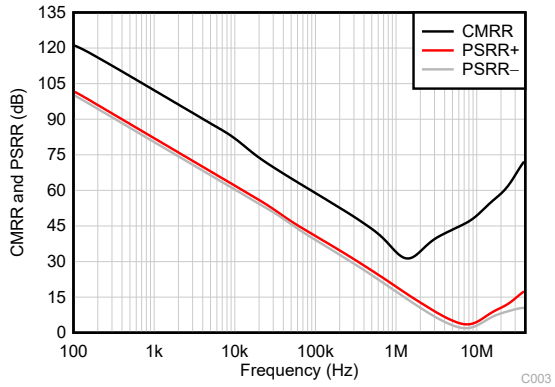
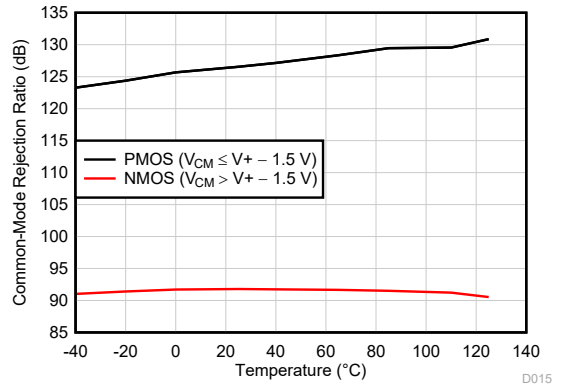
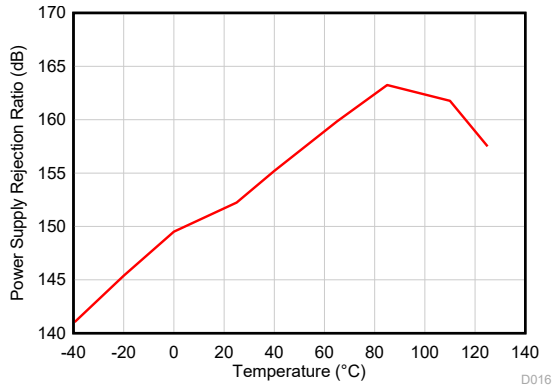


Figure 4-16. CMRR and PSRR vs Frequency



f = 0Hz

Figure 4-17. CMRR vs Temperature (dB)



f = 0Hz

Figure 4-18. PSRR vs Temperature (dB)

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5 Parameter Measurement Information

5.1 Single-Supply Versus Split-Supply Test Circuits

Because the TLC274 and TLC279 are optimized for single-supply operation, circuit configurations used for the various tests often present some inconvenience since the input signal, in many cases, must be offset from ground. This inconvenience can be avoided by testing the device with split supplies and the output load tied to the negative rail. A comparison of single-supply versus split-supply test circuits is shown below. The use of either circuit gives the same result.

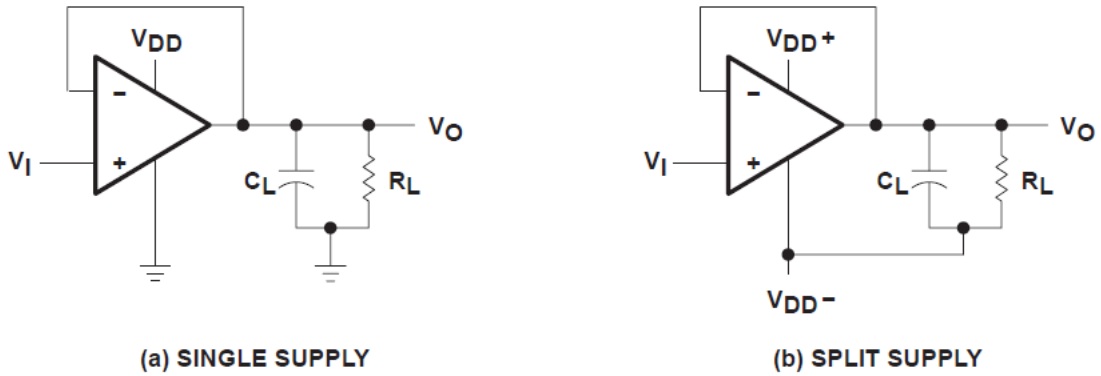

Figure 5-1. Unity-Gain Amplifier

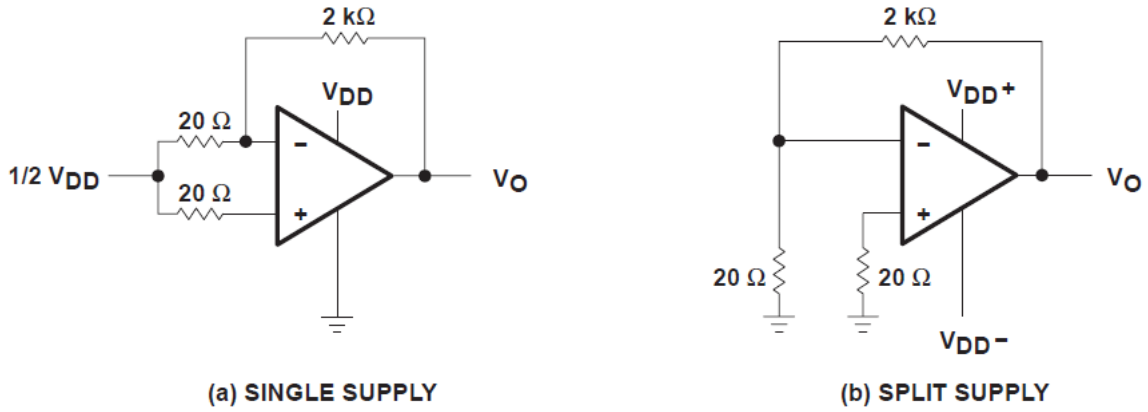

Figure 5-2. Noise-Test Circuit

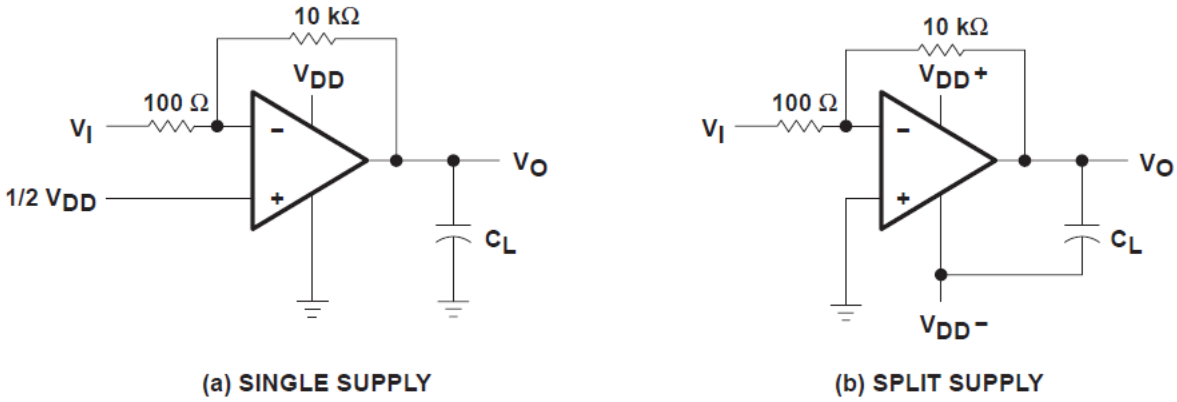

Figure 5-3. Gain-of-100 Inverting Amplifier

5.2 Input Bias Current

Because of the high input impedance of the TLC274 and TLC279 operational amplifiers, attempts to measure the input bias current can result in erroneous readings. The bias current at normal room ambient temperature is typically less than 1pA, a value that is easily exceeded by leakages on the test socket. Two suggestions are offered to avoid erroneous measurements:

1. Isolate the device from other potential leakage sources. Use a grounded shield around and between the device inputs (see Figure 5-4). Leakages that can otherwise flow to the inputs are shunted away.
2. Compensate for the leakage of the test socket by actually performing an input bias current test (using a picoammeter) with no device in the test socket. The actual input bias current can then be calculated by subtracting the open-socket leakage readings from the readings obtained with a device in the test socket.

One word of caution: many automatic testers as well as some bench-top operational amplifier testers use the servo-loop technique with a resistor in series with the device input to measure the input bias current (the voltage drop across the series resistor is measured and the bias current is calculated). This method requires that a device be inserted into the test socket to obtain a correct reading; therefore, an open-socket reading is not feasible using this method.

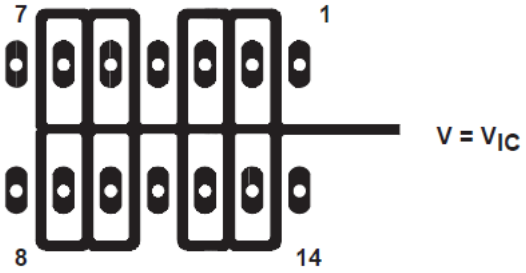

Figure 5-4. Isolation Metal Around Device Inputs (J and N Packages)

5.3 Low-Level Output Voltage

To obtain low-supply-voltage operation, some compromise is necessary in the input stage. This compromise results in the device low-level output being dependent on both the common-mode input voltage level as well as the differential input voltage level. When attempting to correlate low-level output readings with those quoted in the electrical specifications, these two conditions must be observed.

5.4 Input Offset Voltage Temperature Coefficient

Erroneous readings often result from attempts to measure temperature coefficient of input offset voltage. This parameter is actually a calculation using input offset voltage measurements obtained at two different temperatures. When one (or both) of the temperatures is below freezing, moisture can collect on both the device and the test socket. This moisture results in leakage and contact resistance, which can cause erroneous input offset voltage readings. The isolation techniques previously mentioned have no effect on the leakage since the moisture also covers the isolation metal, thereby rendering the method useless. TI also suggested that these measurements be performed at temperatures above freezing to minimize error.

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6 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

6.1 Application Information

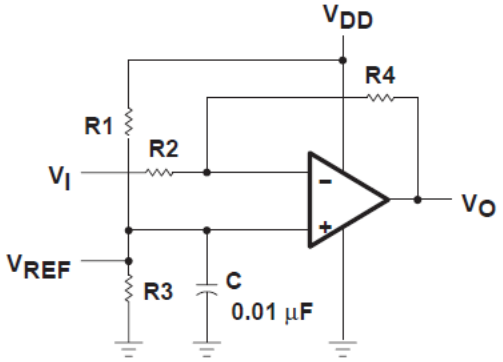
6.1.1 Single-Supply Operation

While the TLC274 and TLC279 perform well using dual power supplies (also called balanced or split supplies), the design is optimized for single-supply operation. This design includes an input common-mode voltage range that encompasses ground as well as an output voltage range that pulls down to ground. The supply voltage range extends down to 3V (C-suffix types), thus allowing operation with supply levels commonly available for TTL and HCMOS; however, for maximum dynamic range, 16V single-supply operation is recommended.

Many single-supply applications require that a voltage be applied to one input to establish a reference level that is above ground. A resistive voltage divider is typically sufficient to establish this reference level (see Figure 6-1). The low input bias current of the TLC274 and TLC279 permits the use of very large resistive values to implement the voltage divider, thus minimizing power consumption.

The TLC274 and TLC279 work well in conjunction with digital logic; however, when powering both linear devices anddigital logic from the same power supply, the following precautions are recommended:

1. Power the linear devices from separate bypassed supply lines (see Figure 6-2); otherwise the linear device supply rails can fluctuate due to voltage drops caused by high switching currents in the digital logic
2. Use proper bypass techniques to reduce the probability of noise-induced errors. Single capacitive decoupling is often adequate; however, high-frequency applications can require R_C decoupling.



$$V_{REF} = V_{DD} \frac{R3}{R1 + R3}$$

$$V_O = (V_{REF} - V_I) \frac{R4}{R2} + V_{REF}$$

Figure 6-1. Inverting Amplifier With Voltage Reference

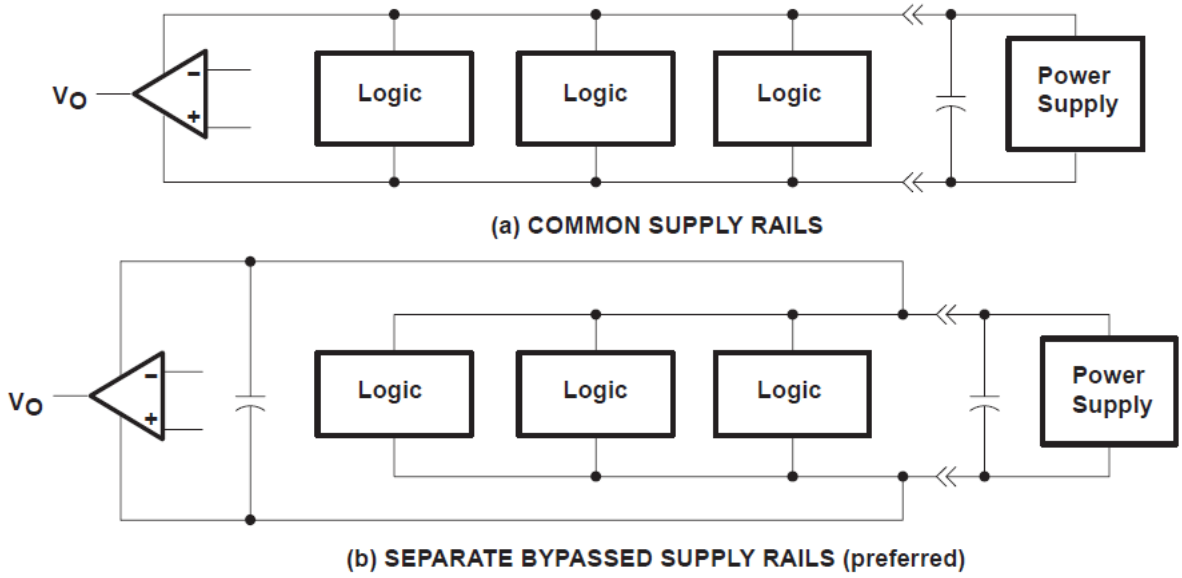


Figure 6-2. Common vs Separate Supply Rails

6.1.2 Input Characteristics

The TLC274 and TLC279 are specified with a minimum and a maximum input voltage that, if exceeded at either input, can cause the device to malfunction. Exceeding this specified range is a common problem, especially in single-supply operation. Note that the lower range limit includes the negative rail, while the upper range limit is specified at V_{DD}− 1V at T_A = 25°C and at V_{DD} −1.5V at all other temperatures.

The use of the polysilicon-gate process and the careful input circuit design gives the TLC274 and TLC279 very good input offset voltage drift characteristics relative to conventional metal-gate processes. Offset voltage drift in CMOS devices is highly influenced by threshold voltage shifts caused by polarization of the phosphorus dopant implanted in the oxide. Placing the phosphorus dopant in a conductor (such as a polysilicon gate) alleviates the polarization problem, thus reducing threshold voltage shifts by more than an order of magnitude. The offset voltage drift with time has been calculated to be typically 0.1μV/month, including the first month of operation.

Because of the extremely high input impedance and resulting low bias current requirements, the TLC274 and TLC279 are well suited for low-level signal processing; however, leakage currents on printed-circuit boards and sockets can easily exceed bias current requirements and cause a degradation in device performance. Including guard rings around inputs (similar to those of Figure 5-4 in Section 5) is good practice. These guards must be driven from a low-impedance source at the same voltage level as the common-mode input (see Figure 6-3).

Unused amplifiers must be connected as grounded unity-gain followers to avoid possible oscillation.

6.1.3 Noise Performance

The noise specifications in operational amplifier circuits are greatly dependent on the current in the first-stage differential amplifier. The low input bias current requirements of the TLC274 and TLC279 result in a very low noise current, which is insignificant in most applications. This feature makes the devices especially favorable over bipolar devices when using values of circuit impedance greater than 50kΩ, since bipolar devices exhibit greater noise currents.

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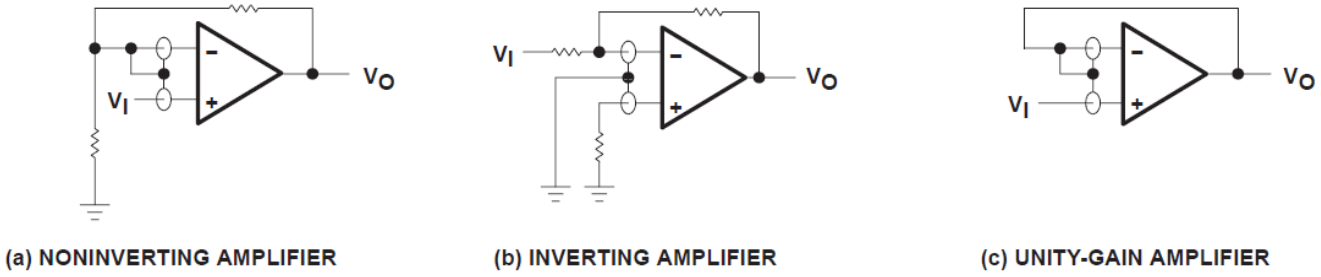

(a) NONINVERTING AMPLIFIER (b) INVERTING AMPLIFIER (c) UNITY-GAIN AMPLIFIER

Figure 6-3. Guard-Ring Schemes

7 Device and Documentation Support

7.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

7.2 Support Resources

TI E2E™ support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

7.3 Trademarks

TI E2E™ is a trademark of Texas Instruments.
All trademarks are the property of their respective owners.

7.4 Electrostatic Discharge Caution

This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

7.5 Glossary

TI Glossary	This glossary lists and explains terms, acronyms, and definitions.

8 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision D (March 2001) to Revision E (January 2026)	Page
• Updated the numbering format for tables, figures, and cross-references throughout the document	1
• Deleted TLC274Y throughout the document	1
• Deleted input offset voltage drift bullet from the *Features*	1
• Deleted trimmed offset voltage bullet from the *Features*	1
• Changed low noise typical from 25nV/√Hz to 10.8nV/√Hz in the *Features*	1
• Deleted reference to LinCMOS throughout the document	1
• Deleted available options table in *Description*	1
• Deleted equivalent schematic figure from the document	1
• Added the *Pin Configuration and Functions* section	3
• Deleted FK package pinout details from the document	3
• Deleted TLC274Y chip information	3
• Deleted all tables in the *Specifications* related to TLC274M, TLC279M and TLC274Y	4
• Deleted M-suffix and FK package related information in the *Absolute Maximum Ratings* table	4
• Deleted the *Dissipation Ratings* table	4
• Deleted M suffix table column in the *Recommended Operating Conditions* table	4
• Changed Input offset Voltage for 274C typical from 1.1mV to 0.12mV in all of the *Electrical Characteristics* tables	5
• Changed Input offset Voltage for 274AC typical from 0.9mV to 0.12mV in all of the *Electrical Characteristics* tables	5
• Changed Input offset Voltage for 274BC typical from 230µV to 0.12mV in all of the *Electrical Characteristics* tables	5

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- Changed Input offset Voltage for 279C typical from 200µV to 0.12mV in all of the *Electrical Characteristics* tables.....5
- Changed Input offset Voltage for 279C maximum at 25°C from 500mV to 900mV in all of the *Electrical Characteristics* tables.....5
- Changed Temperature coefficient of input offset voltage from 1.8µV/°C to 0.3µV/°C in all of the *Electrical Characteristics* tables.....5
- Changed Input offset current from 0.1pA to 10pA in all of the *Electrical Characteristics* tables.....5
- Changed Input bias current from 0.6pA to 10pA in all of the *Electrical Characteristics* tables.....5
- Changed Common-mode input voltage range at 25°C and full range from –0.2V to –0.1V in all of the *Electrical Characteristics* tables.....5
- Changed High-level output voltage at 5V, 25°C, 0°C and 70°C from 3.8V to 4.95V in all of the *Electrical Characteristics* tables.....5
- Changed Large-signal differential voltage amplification at 25°C from 23V/mV to 1000V/mV in all of the *Electrical Characteristics* tables.....5
- Deleted Large-signal differential voltage amplification at 0°C and 70°C in all of the *Electrical Characteristics* tables.....5
- Deleted Common-mode rejection ratio at 0°C and 70°C in all of the *Electrical Characteristics* tables.....5
- Changed Supply-voltage rejection ratio at 25°C from 95dB to 120dB in all of the *Electrical Characteristics* tables.....5
- Deleted Supply-voltage rejection ratio at 0°C and 70°C in all of the *Electrical Characteristics* tables.....5
- Changed Supply current(four amplifiers) at 25°C from 2.7mA to 2.24mA in all of the *Electrical Characteristics* tables.....5
- Deleted Supply current(four amplifiers) typical at 0°C and 70°C in all of the *Electrical Characteristics* tables.. 5
- Changed High-level output voltage at 10V, 25°C from 8.5V to 9.95V in the 10V *Electrical Characteristics* table 6
- Deleted High-level output voltage at 10V, 0°C and 70°C in the 10V *Electrical Characteristics* table.....6
- Changed Supply current (four amplifiers) at 25°C from 3.8mA to 2.24mA in the 10V *Electrical Characteristics* table.....6
- Changed Input offset voltage for TLC279I at full range from 2900µV to 2000µV in the 10V *Electrical Characteristics* table 8
- Changed Large-signal differential voltage amplification at 25°C typical changed from 10V/mV to 5V/mV in the 10V *Electrical Characteristics* table.....8
- Changed Large-signal differential voltage amplification at –40°C and 85°C typical changed from 7V/mV to 3.5V/mV in the 10V *Electrical Characteristics* table.....8
- Changed Equivalent input noise voltage from 25nV/√Hz to 10.8nV/√Hz in the *Operating Characteristics* table. 9
- Changed V_{IPP} from 1V to 100mV and 2.5V to 1V in the *Operating Characteristics* table.....9
- Changed Maximum output-swing bandwidth from 320kHz to 10kHz in the *Operating Characteristics* table.....9
- Changed Slew Rate at Unity gain typical at V_{IPP} 100mV from 3.6V/µs to 0.5V/µs and at 1V from 2.9V/µs to 21V/µs in the *Operating Characteristics* table.....9
- Changed Unity gain bandwidth typical from 1.7MHz to 4.5MHz in the *Operating Characteristics* table.....9
- Changed Phase Margin typical from 46° to 60° in the *Operating Characteristics* table.....9
- Deleted all values for –40°C and 85°C in the *Operating Characteristics* table.....9
- Added TLC274C, TLC274AC TLC274BC, TLC279C in the *Operating Characteristics* table.....9
- Updated *Typical Characteristics* plots as per latest data.....10
- Deleted *Full power response* and *Test time section*.....14
- Deleted *Output Characteristics*, *Feedback*, *Electrostatic Discharge Protection*, *Latch-Up* section.....16

9 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package | Pins	Package qty | Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
TLC274ACD	Obsolete	Production	SOIC (D) | 14	-	-	Call TI	Call TI	0 to 70	TLC274AC
TLC274ACDR	Active	Production	SOIC (D) | 14	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	TLC274AC
TLC274ACDR.A	Active	Production	SOIC (D) | 14	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	TLC274AC
TLC274ACN	Active	Production	PDIP (N) | 14	25 | TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	TLC274ACN
TLC274ACN.A	Active	Production	PDIP (N) | 14	25 | TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	TLC274ACN
TLC274ACNE4	Active	Production	PDIP (N) | 14	25 | TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	TLC274ACN
TLC274AID	Obsolete	Production	SOIC (D) | 14	-	-	Call TI	Call TI	-40 to 85	TLC274AI
TLC274AIDR	Active	Production	SOIC (D) | 14	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TLC274AI
TLC274AIDR.A	Active	Production	SOIC (D) | 14	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TLC274AI
TLC274AIN	Active	Production	PDIP (N) | 14	25 | TUBE	Yes	NIPDAU	N/A for Pkg Type	-40 to 85	TLC274AIN
TLC274AIN.A	Active	Production	PDIP (N) | 14	25 | TUBE	Yes	NIPDAU	N/A for Pkg Type	-40 to 85	TLC274AIN
TLC274BCD	Obsolete	Production	SOIC (D) | 14	-	-	Call TI	Call TI	0 to 70	TLC274BC
TLC274BCDR	Active	Production	SOIC (D) | 14	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	TLC274BC
TLC274BCDR.A	Active	Production	SOIC (D) | 14	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	TLC274BC
TLC274BCN	Active	Production	PDIP (N) | 14	25 | TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	TLC274BCN
TLC274BCN.A	Active	Production	PDIP (N) | 14	25 | TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	TLC274BCN
TLC274BCNE4	Active	Production	PDIP (N) | 14	25 | TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	TLC274BCN
TLC274BCNS	Active	Production	SOP (NS) | 14	50 | TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	TLC274B
TLC274BCNS.A	Active	Production	SOP (NS) | 14	50 | TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	TLC274B
TLC274BID	Obsolete	Production	SOIC (D) | 14	-	-	Call TI	Call TI	-40 to 85	TLC274BI
TLC274BIDR	Active	Production	SOIC (D) | 14	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TLC274BI
TLC274BIDR.A	Active	Production	SOIC (D) | 14	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TLC274BI
TLC274BIDRG4	Active	Production	SOIC (D) | 14	2500 | LARGE T&R	-	Call TI	Call TI	-40 to 85	
TLC274BIN	Active	Production	PDIP (N) | 14	25 | TUBE	Yes	NIPDAU	N/A for Pkg Type	-40 to 85	TLC274BIN
TLC274BIN.A	Active	Production	PDIP (N) | 14	25 | TUBE	Yes	NIPDAU	N/A for Pkg Type	-40 to 85	TLC274BIN
TLC274CD	Obsolete	Production	SOIC (D) | 14	-	-	Call TI	Call TI	0 to 70	TLC274C
TLC274CDB	Active	Production	SSOP (DB) | 14	80 | TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	P274
TLC274CDB.A	Active	Production	SSOP (DB) | 14	80 | TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	P274
TLC274CDBR	Active	Production	SSOP (DB) | 14	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	P274

Orderable part number	Status (1)	Material type (2)	Package | Pins	Package qty | Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
TLC274CDBR.A	Active	Production	SSOP (DB) | 14	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	P274
TLC274CDR	Active	Production	SOIC (D) | 14	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	TLC274C
TLC274CDR.A	Active	Production	SOIC (D) | 14	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	TLC274C
TLC274CN	Active	Production	PDIP (N) | 14	25 | TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	TLC274CN
TLC274CN.A	Active	Production	PDIP (N) | 14	25 | TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	TLC274CN
TLC274CNE4	Active	Production	PDIP (N) | 14	25 | TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	TLC274CN
TLC274CNS	Active	Production	SOP (NS) | 14	50 | TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	TLC274
TLC274CNS.A	Active	Production	SOP (NS) | 14	50 | TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	TLC274
TLC274CNSR	Active	Production	SOP (NS) | 14	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	TLC274
TLC274CNSR.A	Active	Production	SOP (NS) | 14	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	TLC274
TLC274CPW	Obsolete	Production	TSSOP (PW) | 14	-	-	Call TI	Call TI	0 to 70	P274
TLC274CPWR	Active	Production	TSSOP (PW) | 14	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	P274
TLC274CPWR.A	Active	Production	TSSOP (PW) | 14	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	P274
TLC274ID	Obsolete	Production	SOIC (D) | 14	-	-	Call TI	Call TI	-40 to 85	TLC274I
TLC274IDR	Active	Production	SOIC (D) | 14	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TLC274I
TLC274IDR.A	Active	Production	SOIC (D) | 14	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TLC274I
TLC274IN	Active	Production	PDIP (N) | 14	25 | TUBE	Yes	NIPDAU	N/A for Pkg Type	-40 to 85	TLC274IN
TLC274IN.A	Active	Production	PDIP (N) | 14	25 | TUBE	Yes	NIPDAU	N/A for Pkg Type	-40 to 85	TLC274IN
TLC274INE4	Active	Production	PDIP (N) | 14	25 | TUBE	Yes	NIPDAU	N/A for Pkg Type	-40 to 85	TLC274IN
TLC274IPWR	Active	Production	TSSOP (PW) | 14	2000 | LARGE T&R	Yes	NIPDAU | SN	Level-1-260C-UNLIM	-40 to 85	Y274
TLC274IPWR.A	Active	Production	TSSOP (PW) | 14	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	Y274
TLC274IPWRG4	Active	Production	TSSOP (PW) | 14	2000 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	Y274
TLC274MD	Obsolete	Production	SOIC (D) | 14	-	-	Call TI	Call TI	-55 to 125	
TLC274MDG4	Obsolete	Production	SOIC (D) | 14	-	-	Call TI	Call TI	-55 to 125	
TLC274MDRG4	Active	Production	SOIC (D) | 14	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	TLC274M
TLC274MDRG4.A	Active	Production	SOIC (D) | 14	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	TLC274M
TLC279CD	Obsolete	Production	SOIC (D) | 14	-	-	Call TI	Call TI	0 to 70	TLC279C
TLC279CDR	Active	Production	SOIC (D) | 14	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	TLC279C
TLC279CDR.A	Active	Production	SOIC (D) | 14	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	0 to 70	TLC279C
TLC279CN	Active	Production	PDIP (N) | 14	25 | TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	TLC279CN
TLC279CN.A	Active	Production	PDIP (N) | 14	25 | TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	TLC279CN

Orderable part number	Status (1)	Material type (2)	Package | Pins	Package qty | Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
TLC279ID	Obsolete	Production	SOIC (D) | 14	-	-	Call TI	Call TI	-40 to 85	TLC279I
TLC279IDR	Active	Production	SOIC (D) | 14	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TLC279I
TLC279IDR.A	Active	Production	SOIC (D) | 14	2500 | LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TLC279I
TLC279IN	Active	Production	PDIP (N) | 14	25 | TUBE	Yes	NIPDAU	N/A for Pkg Type	-40 to 85	TLC279IN
TLC279IN.A	Active	Production	PDIP (N) | 14	25 | TUBE	Yes	NIPDAU	N/A for Pkg Type	-40 to 85	TLC279IN

(1) **Status:** For more details on status, see our product life cycle.

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

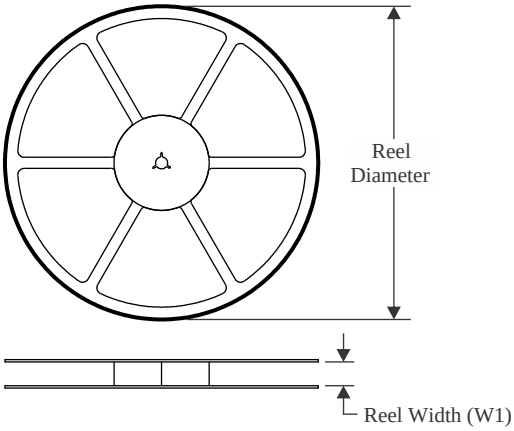
Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

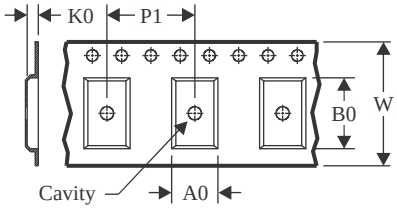
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

TAPE AND REEL INFORMATION

REEL DIMENSIONS

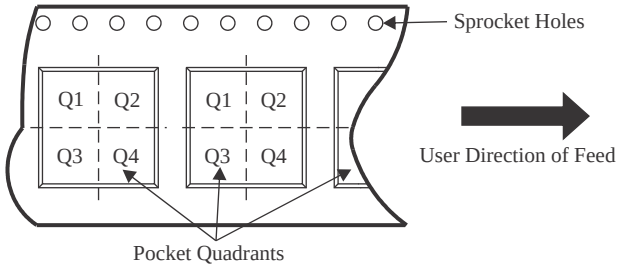


TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

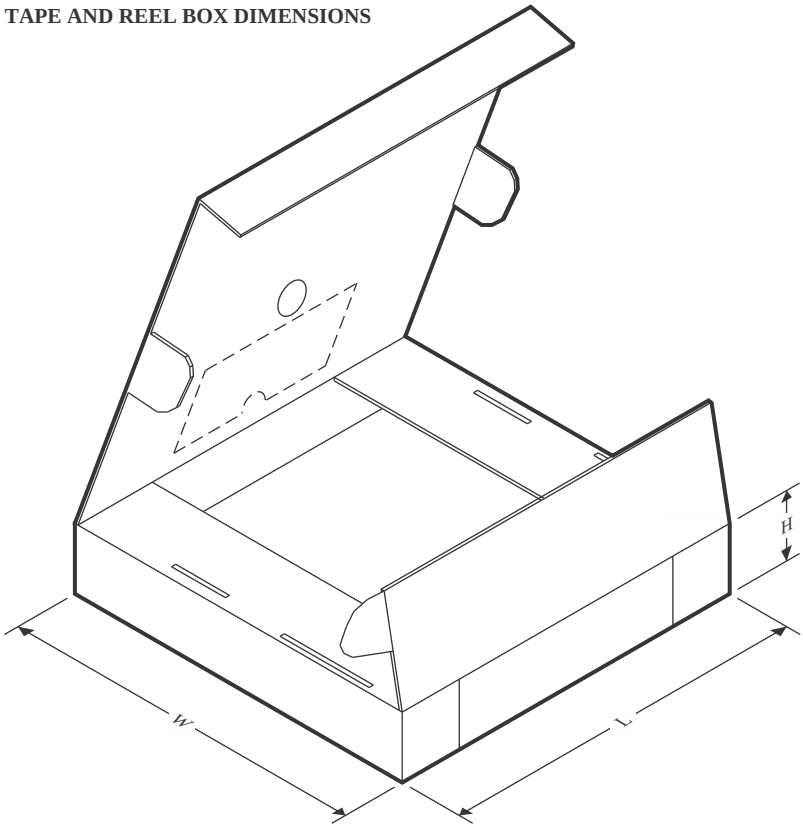
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TLC274ACDR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
TLC274AIDR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
TLC274BCDR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
TLC274BIDR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
TLC274CDBR	SSOP	DB	14	2000	330.0	16.4	8.35	6.6	2.4	12.0	16.0	Q1
TLC274CDR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
TLC274CNSR	SOP	NS	14	2000	330.0	16.4	8.1	10.4	2.5	12.0	16.0	Q1
TLC274CPWR	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
TLC274CPWR	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
TLC274IDR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
TLC274IPWR	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
TLC274IPWRG4	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
TLC274IPWRG4	TSSOP	PW	14	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
TLC274MDRG4	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
TLC279CDR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
TLC279IDR	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1

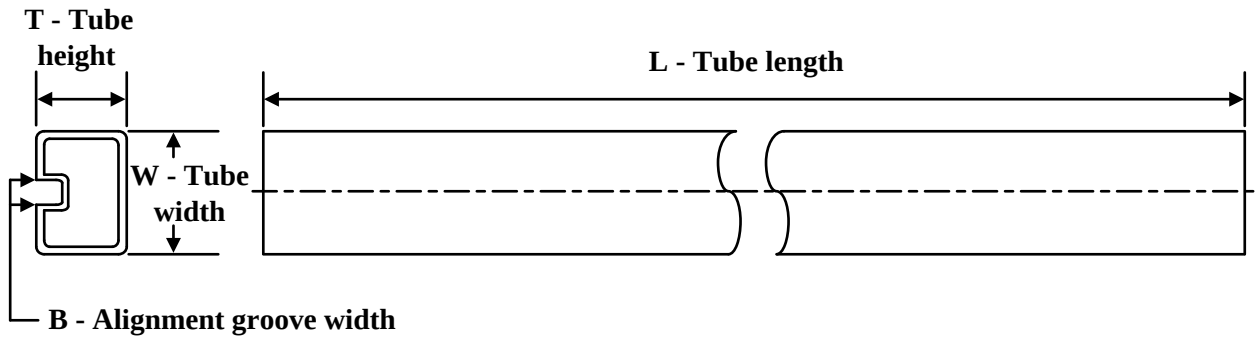
TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TLC274ACDR	SOIC	D	14	2500	353.0	353.0	32.0
TLC274AIDR	SOIC	D	14	2500	353.0	353.0	32.0
TLC274BCDR	SOIC	D	14	2500	353.0	353.0	32.0
TLC274BIDR	SOIC	D	14	2500	353.0	353.0	32.0
TLC274CDBR	SSOP	DB	14	2000	353.0	353.0	32.0
TLC274CDR	SOIC	D	14	2500	333.2	345.9	28.6
TLC274CNSR	SOP	NS	14	2000	353.0	353.0	32.0
TLC274CPWR	TSSOP	PW	14	2000	353.0	353.0	32.0
TLC274CPWR	TSSOP	PW	14	2000	353.0	353.0	32.0
TLC274IDR	SOIC	D	14	2500	353.0	353.0	32.0
TLC274IPWR	TSSOP	PW	14	2000	356.0	356.0	35.0
TLC274IPWRG4	TSSOP	PW	14	2000	353.0	353.0	32.0
TLC274IPWRG4	TSSOP	PW	14	2000	356.0	356.0	35.0
TLC274MDRG4	SOIC	D	14	2500	353.0	353.0	32.0
TLC279CDR	SOIC	D	14	2500	353.0	353.0	32.0
TLC279IDR	SOIC	D	14	2500	353.0	353.0	32.0

TUBE



*All dimensions are nominal

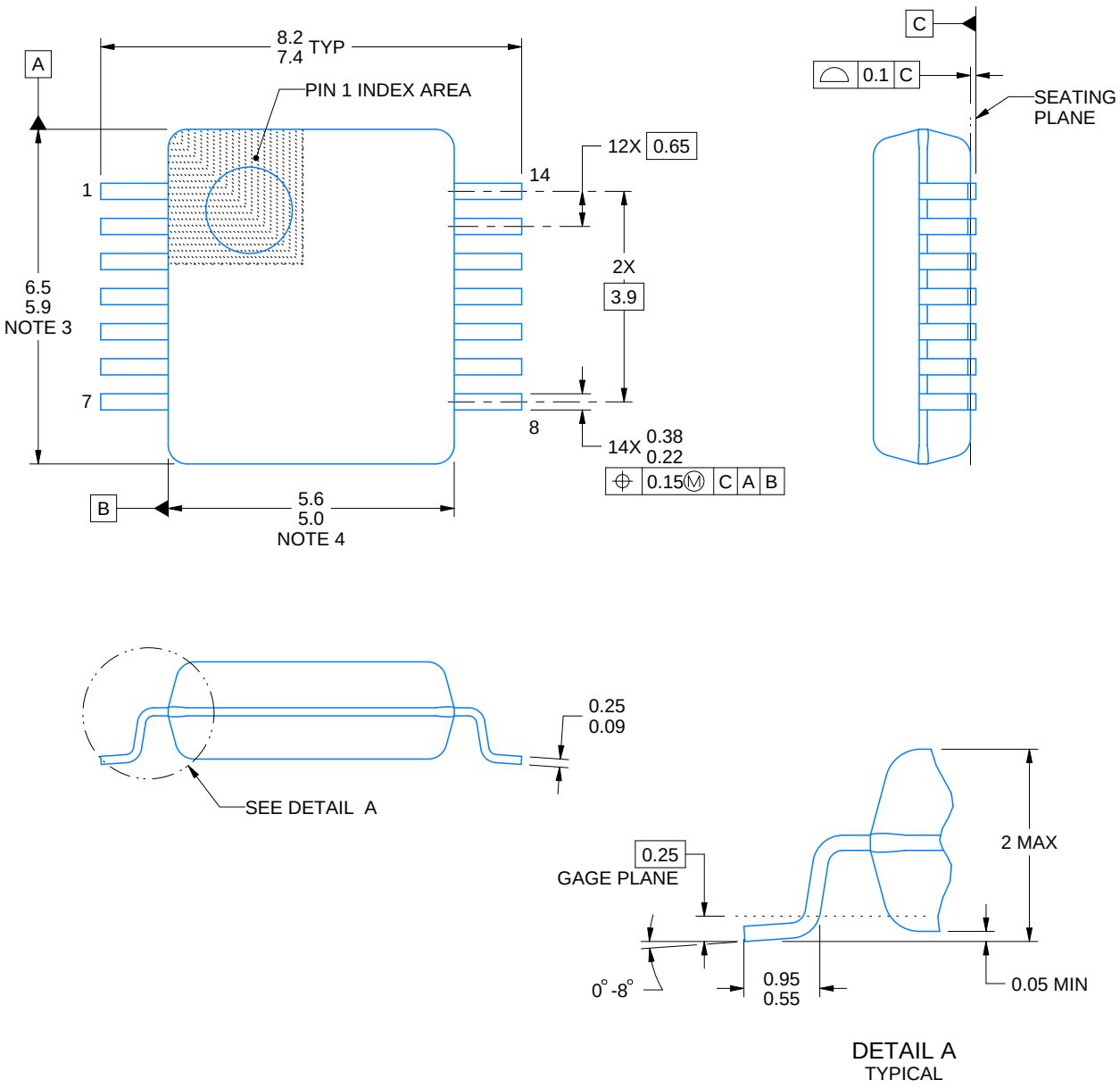
Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
TLC274ACN	N	PDIP	14	25	506	13.97	11230	4.32
TLC274ACN.A	N	PDIP	14	25	506	13.97	11230	4.32
TLC274ACNE4	N	PDIP	14	25	506	13.97	11230	4.32
TLC274AIN	N	PDIP	14	25	506	13.97	11230	4.32
TLC274AIN.A	N	PDIP	14	25	506	13.97	11230	4.32
TLC274BCN	N	PDIP	14	25	506	13.97	11230	4.32
TLC274BCN.A	N	PDIP	14	25	506	13.97	11230	4.32
TLC274BCNE4	N	PDIP	14	25	506	13.97	11230	4.32
TLC274BCNS	NS	SOP	14	50	530	10.5	4000	4.1
TLC274BCNS.A	NS	SOP	14	50	530	10.5	4000	4.1
TLC274BIN	N	PDIP	14	25	506	13.97	11230	4.32
TLC274BIN.A	N	PDIP	14	25	506	13.97	11230	4.32
TLC274CDB	DB	SSOP	14	80	530	10.5	4000	4.1
TLC274CDB.A	DB	SSOP	14	80	530	10.5	4000	4.1
TLC274CN	N	PDIP	14	25	506	13.97	11230	4.32
TLC274CN.A	N	PDIP	14	25	506	13.97	11230	4.32
TLC274CNE4	N	PDIP	14	25	506	13.97	11230	4.32
TLC274CNS	NS	SOP	14	50	530	10.5	4000	4.1
TLC274CNS.A	NS	SOP	14	50	530	10.5	4000	4.1
TLC274IN	N	PDIP	14	25	506	13.97	11230	4.32
TLC274IN.A	N	PDIP	14	25	506	13.97	11230	4.32
TLC274INE4	N	PDIP	14	25	506	13.97	11230	4.32
TLC279CN	N	PDIP	14	25	506	13.97	11230	4.32
TLC279CN.A	N	PDIP	14	25	506	13.97	11230	4.32
TLC279IN	N	PDIP	14	25	506	13.97	11230	4.32
TLC279IN.A	N	PDIP	14	25	506	13.97	11230	4.32

PACKAGE OUTLINE

DB0014A

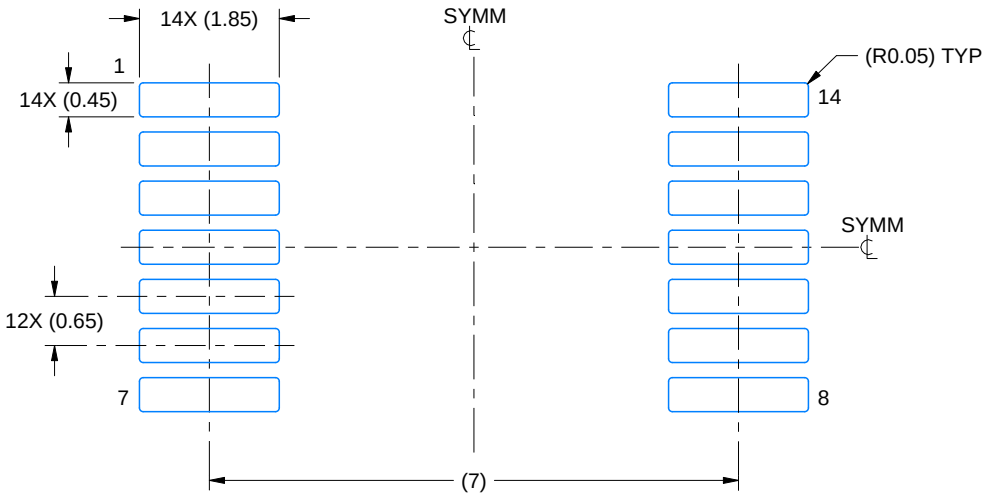
SSOP - 2 mm max height

SMALL OUTLINE PACKAGE

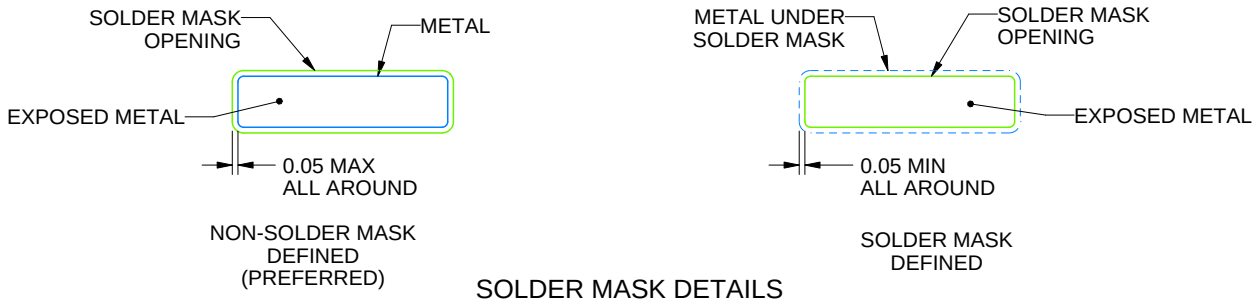


NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. Reference JEDEC registration MO-150.



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 10X

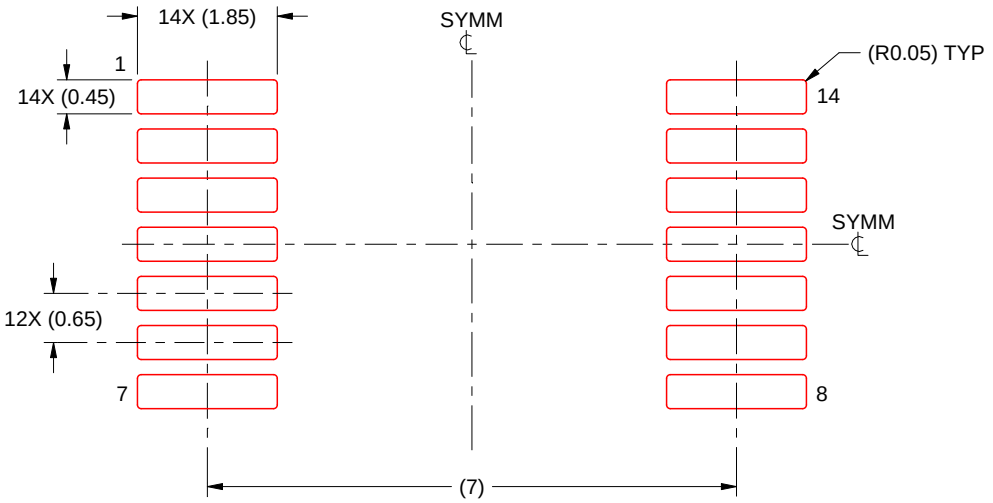


SOLDER MASK DETAILS

4220762/A 05/2024

NOTES: (continued)

5. Publication IPC-7351 may have alternate designs.
6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE: 10X

4220762/A 05/2024

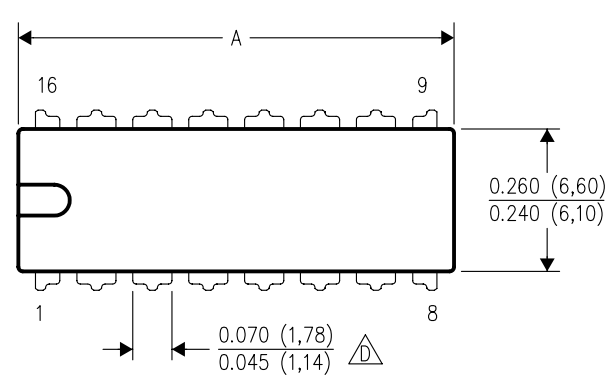
NOTES: (continued)

7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
8. Board assembly site may have different recommendations for stencil design.

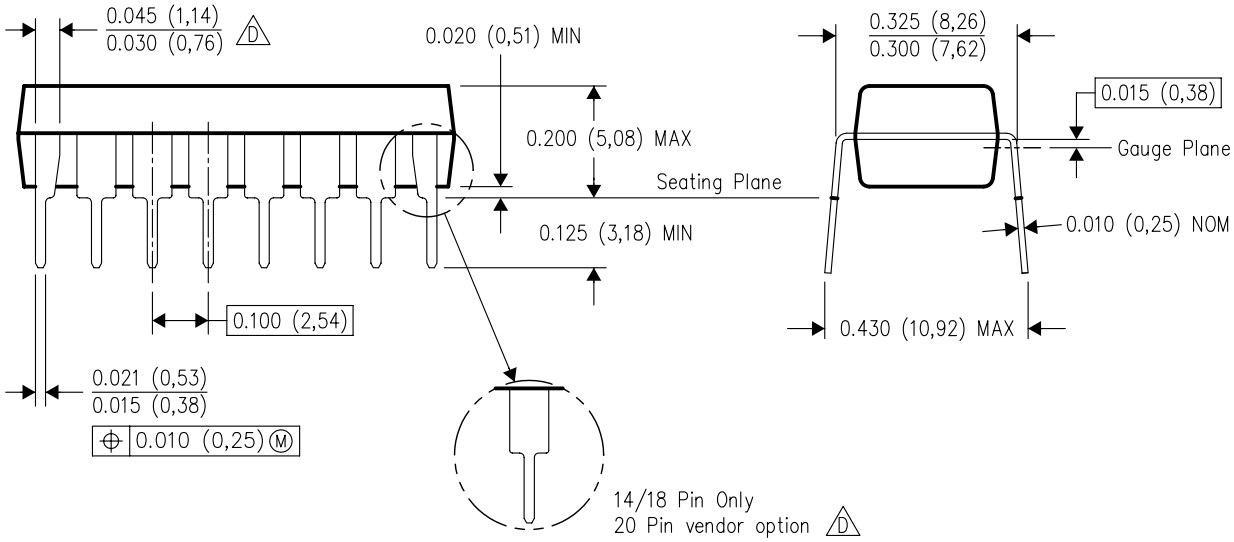
N (R–PDIP–T**)

PLASTIC DUAL–IN–LINE PACKAGE

16 PINS SHOWN



DIM \ PINS **	14	16	18	20
A MAX	0.775 (19,69)	0.775 (19,69)	0.920 (23,37)	1.060 (26,92)
A MIN	0.745 (18,92)	0.745 (18,92)	0.850 (21,59)	0.940 (23,88)
MS–001 VARIATION (C)	AA	BB	AC	AD



4040049/E 12/2002

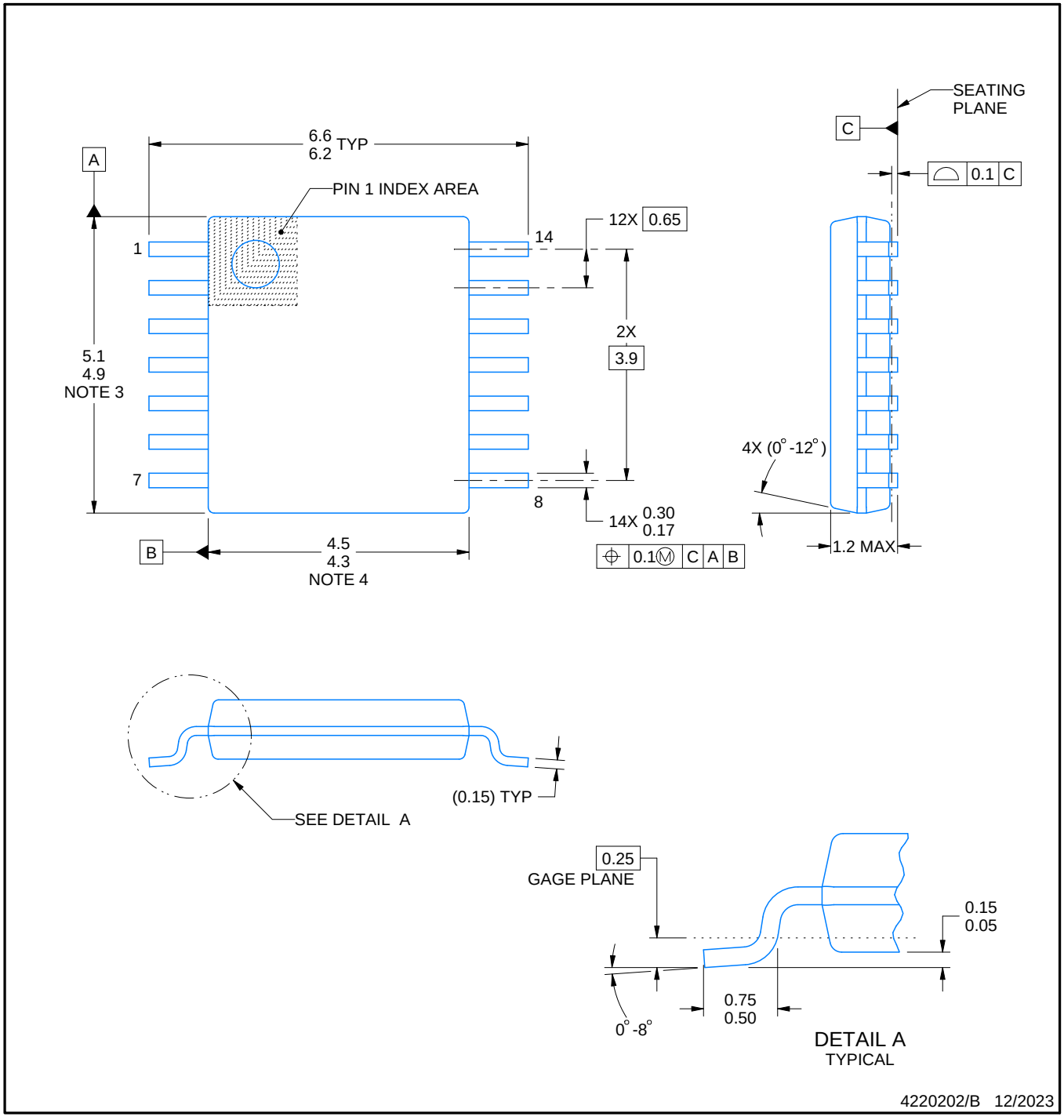
NOTES:
A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. Falls within JEDEC MS–001, except 18 and 20 pin minimum body length (Dim A).
D. The 20 pin end lead shoulder width is a vendor option, either half or full width.

PACKAGE OUTLINE

PW0014A

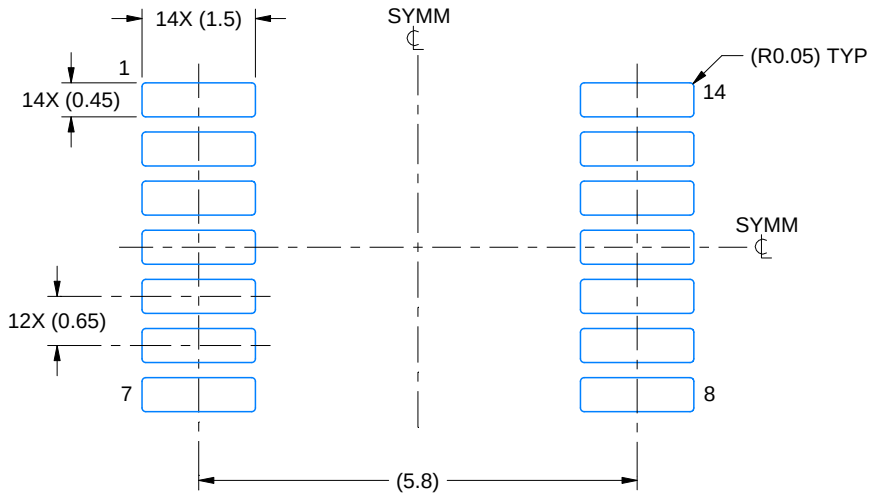
TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE

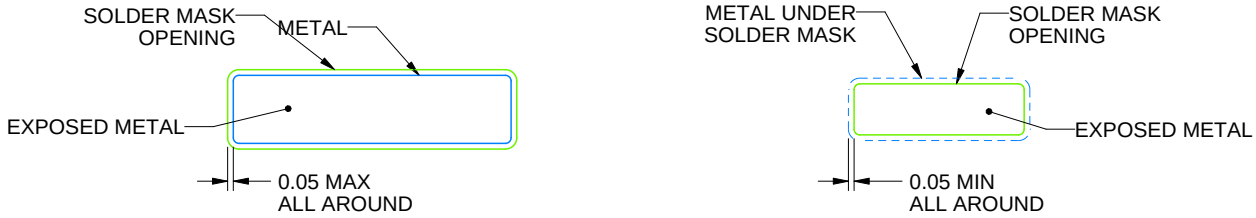


NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-153.



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 10X

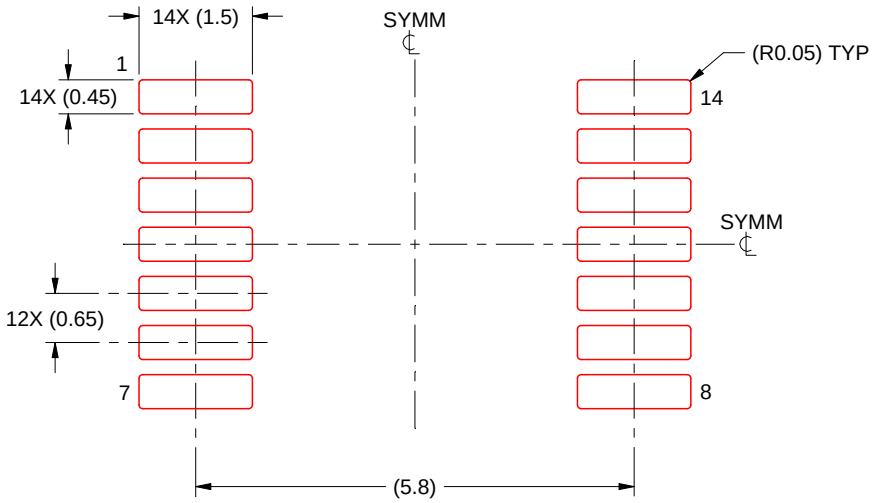


SOLDER MASK DETAILS

4220202/B 12/2023

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

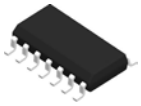


SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE: 10X

4220202/B 12/2023

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

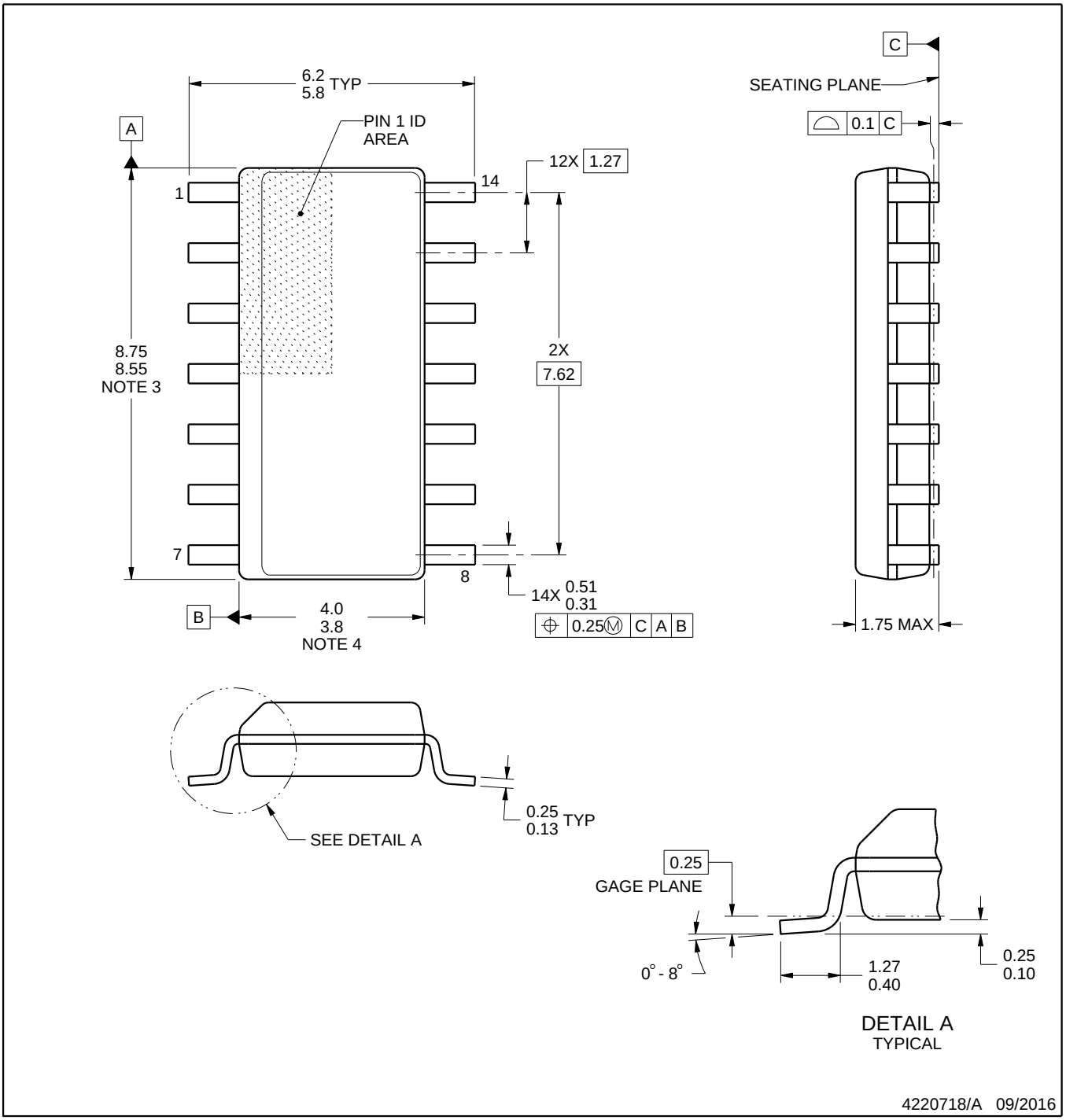


PACKAGE OUTLINE

D0014A

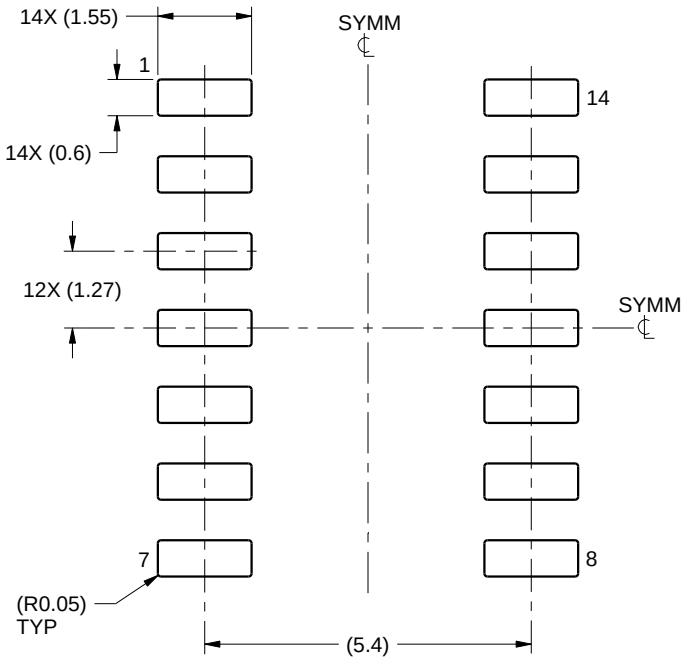
SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT

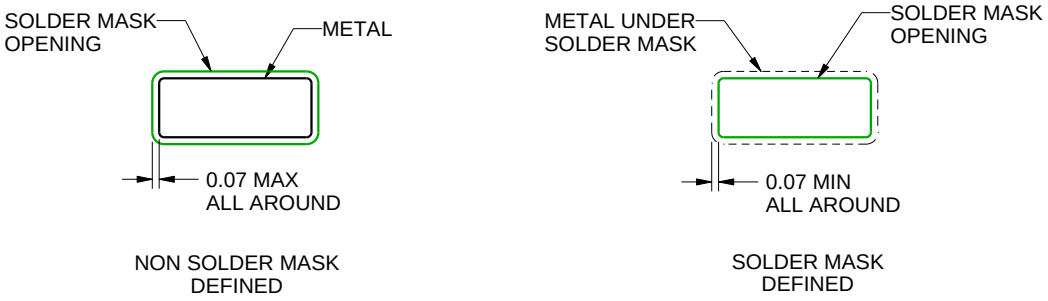


NOTES:

1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm, per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm, per side.
5. Reference JEDEC registration MS-012, variation AB.



LAND PATTERN EXAMPLE
SCALE:8X



SOLDER MASK DETAILS

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NOTES: (continued)

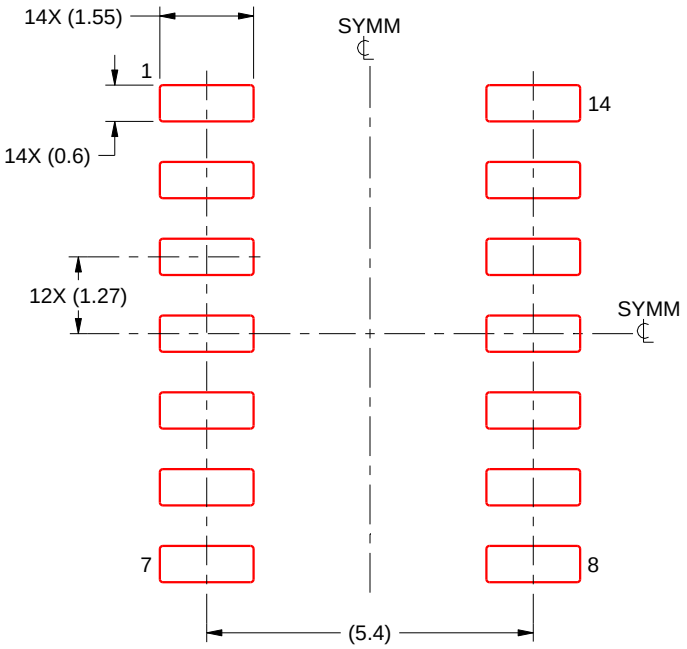
6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

EXAMPLE STENCIL DESIGN

D0014A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE:8X

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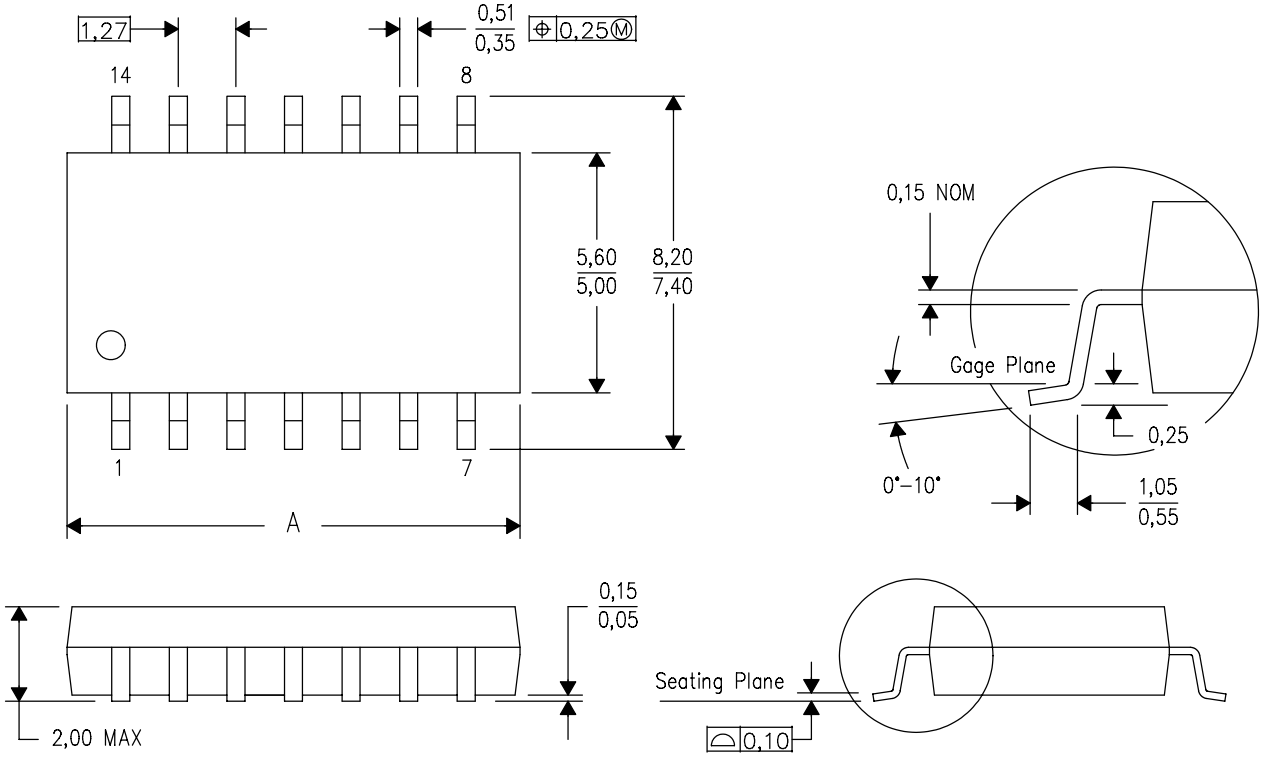
NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

MECHANICAL DATA

NS (R-PDSO-G)** **PLASTIC SMALL-OUTLINE PACKAGE**

14-PINS SHOWN



DIM \ PINS **	14	16	20	24
A MAX	10,50	10,50	12,90	15,30
A MIN	9,90	9,90	12,30	14,70

4040062/C 03/03

NOTES:
A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.

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